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# Stabilization of Silicon—Carbon Mixed Oxides

Yuzhong Wang, Mingwei Chen, Yaoming Xie, Pingrong Wei, Henry F. Schaefer, III, and Gregory H. Robinson\*

Department of Chemistry and the Center for Computational Chemistry, The University of Georgia, Athens, Georgia 30602-2556, United States

Supporting Information

ABSTRACT: The first carbene-stabilized silicon—carbon mixed oxide, (SiO<sub>2</sub>)<sub>2</sub>CO<sub>2</sub> (4), was synthesized by CO<sub>2</sub> oxidation of either carbene-stabilized disilicon, L:Si=Si:L  $(L: = :C\{N(2,6-Pr_{2}^{i}C_{6}H_{3})CH\}_{2})$  (1), or carbene-stabilized Si<sub>2</sub>O<sub>3</sub> (2) (which can be obtained via N<sub>2</sub>O oxidation of 1). The structure and bonding of 4 was probed by both experimental and computational methods.

he chemistry of the two simplest oxides of carbon, carbon monoxide and carbon dioxide, is exceedingly well developed. Considering the pejorative environmental impact of carbon dioxide, a principal hydrocarbon combustion product,<sup>2</sup> the chemical utilization of CO<sub>2</sub> as a renewable carbon resource is attracting increasing attention.<sup>3,4</sup> The oligomerization of CO2, a unimolecular gas, to form dimers [1,3-dioxetanedione (Figure 1a) and 1,2-dioxetanedione

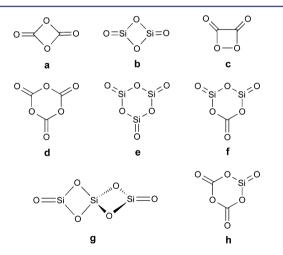


Figure 1. Oligomers of CO<sub>2</sub> and SiO<sub>2</sub> (a-e and g), (SiO<sub>2</sub>)<sub>2</sub>CO<sub>2</sub> (f), and  $SiO_2(CO_2)_2$  (h).

(Figure 1c)] and a cyclic trimer [1,3,5-trioxanetrione (Figure 1d)] are energetically costly.<sup>5</sup> Notably, oligomers of carbon dioxide (a, c, and d in Figure 1) have been proposed as intermediates in the formation of an extended CO<sub>2</sub> solid.<sup>6,7</sup>

In contrast to molecular CO2, naturally occurring silica (SiO<sub>2</sub>) is a network solid wherein each tetrahedrally coordinated silicon atom is bound to four oxygen atoms. Due to highly reactive silicon-oxygen double bonds, as well as low-oxidation state silicon atoms, molecular SiO<sub>2</sub> and other

simple silicon oxides have remained elusive. 9-15 Recently, this laboratory synthesized a carbene-stabilized Si<sub>2</sub>O<sub>3</sub> complex [L:  $(O)Si(\mu-O)Si(O):L$  (2)] and a carbene-stabilized  $Si_2O_4$ complex [L:(O)Si( $\mu$ -O)<sub>2</sub>Si(O):L (3)] via N<sub>2</sub>O (Scheme 2) and O2 oxidation of the soluble L:Si=Si:L complex (L: =  $:C\{N(2,6-Pr_2^iC_6H_3)CH\}_2)$  (1), respectively. <sup>16</sup> While  $Si_2O_4$ , the dimer of SiO2, was experimentally realized in 3, the cyclic isomer of trimeric SiO<sub>2</sub> (Figure 1e) has only been computationally studied. Significantly, the cyclic isomer of (SiO<sub>2</sub>)<sub>3</sub> (Figure 1e) is energetically less favored than the isomer with a double-oxygen bridged structure (Figure 1g).<sup>17</sup>

Silicon carbide (SiC), possessing native silicon dioxide (SiO<sub>2</sub>), is regarded as a wide-band gap (WBG) semiconductor. 18 However, its utility in electronic devices has been impeded by the poor SiC-SiO<sub>2</sub> interface quality. 19-21 Consequently, investigations of the structural properties of the SiC-SiO<sub>2</sub> interfaces have been increasing. The possibility of the formation of crystalline phases for silicon oxycarbide (i.e., Si<sub>2</sub>CO<sub>6</sub>) near the SiC-SiO<sub>2</sub> interfaces has been theoretically studied.21 It is noteworthy that the chemical properties of molecular  $(SiO_2)_2CO_2$  (Figure 1f) and  $SiO_2(CO_2)_2$  (Figure 1h), valence isoelectronic with (CO<sub>2</sub>)<sub>3</sub> (Figure 1d) and (SiO<sub>2</sub>)<sub>3</sub> (Figure 1e), remain unexplored owing to their high reactivity. Although bulk SiO<sub>2</sub> is quite inert relative to CO<sub>2</sub> under ambient conditions, the pressure-induced reaction between CO2 and silicalite, a microporous SiO2 zeolite, has been observed (at 18-26 GPa), giving a silicon carbonate phase.<sup>22</sup> We were curious if molecular silicon oxides would react with gaseous CO2 under ambient conditions, possibly forming a new type of silicon-carbon mixed oxides. Carbene-stabilized silicon oxides (2 and 3)<sup>16</sup> provide a unique platform from which this chemistry may be approached. Herein, we report the molecular structure<sup>23</sup> and computational<sup>23</sup> analysis of carbene-stabilized (SiO<sub>2</sub>)<sub>2</sub>CO<sub>2</sub> (4), which was synthesized via CO<sub>2</sub> oxidation of either 1 or 2.23 To the best of our knowledge, compound 4 represents the first compound containing a carbon-silicon mixed oxide core, prepared under ambient conditions.

Since the discovery of carbon dioxide oxidation of decamethylsilicocene nearly two decades ago, 24 CO2 has been utilized as an oxidant for various low oxidation state group 14 compounds [i.e., disilenes, 25 coordinated disilyne (5 in Scheme 1),<sup>26</sup> amido-digermyne (7 in Scheme 1),<sup>27</sup> and silylenes<sup>28,29</sup>].

This laboratory synthesized the first carbene-stabilized disilicon(0) complex (1 in Scheme 2) $^{30}$  and subsequently

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Scheme 1. CO<sub>2</sub> Oxidation of Base-Stabilized Disilyne and Amido-digermyne

Scheme 2. Synthesis of Compound 4

explored its reactivity toward main group (BH<sub>3</sub>)<sup>31</sup> and transition metal (CuCl)<sup>32</sup> moieties. Encouraged by our recent synthesis of carbene-stabilized  $P_2O_4^{\ 33}$  through  $O_2$  oxidation of carbene-stabilized  $P_2^{\ 34}$  we investigated the  $O_2$  and  $N_2O$ oxidation of 1.16 Considering its dual reactive sites, the Si=Si double bond and the silicon-based lone pair, 1 was also expected to exhibit unusual reactivity toward CO2. Indeed, in contrast to the CO<sub>2</sub>-mediated transformation of disilene to oxadisiletane, 25 reaction of 1 (red color) with CO2 resulted in colorless 4 (49.3% yield), which involved the cleavage of a Si= Si double bond as a result of the insertions of an oxygen atom and a CO<sub>3</sub> unit between two silicon atoms (Scheme 2). In addition to the direct transformation of 1 to 4, we discovered that the CO<sub>2</sub> oxidation of carbene-stabilized Si<sub>2</sub>O<sub>3</sub> (2) also afforded 4 (54.2% yield) (Scheme 2) via the insertion of the  $CO_3$  unit into the Si-Si  $\sigma$ -bond in 2. Notably, the  $CO_2$ mediated insertions of oxygen (and CO<sub>3</sub>) into the Si-Si and Ge-Ge single bonds have been observed in the synthesis of 6 and 8, respectively (Scheme 1). $^{26,27}$  In contrast to 2, reaction of carbene-stabilized Si<sub>2</sub>O<sub>4</sub> (3) with CO<sub>2</sub> only resulted in immediate decomposition, giving L:CO2 as the only characterized byproduct. Moreover, reaction of either 1 or 2 with excess  $CO_2$ , or combining 4 with  $CO_2$  only gave the  $L:CO_2$  adduct and uncharacterized silicon—carbon-based oxide powder, suggesting the importance of controlling the amount of  $CO_2$  added to the reaction system.

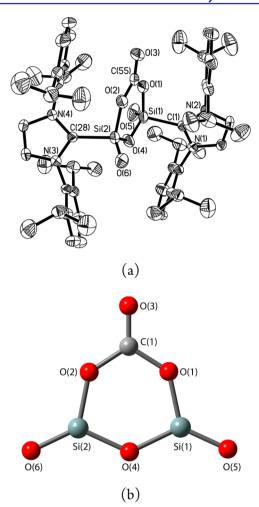
The imidazole <sup>1</sup>H NMR resonance (in C<sub>6</sub>D<sub>6</sub>) shifts upfield from 1 (6.58 ppm) to 2 (6.30 ppm), 3 (6.32 ppm), 16,30 and then to 4 (6.20 ppm). Meanwhile, the singlet <sup>29</sup>Si NMR resonance (in THF-d8) shifts dramatically upfield from 1 (224.5 ppm) to 2 (-49.1 ppm), 3 (-76.3 ppm), <sup>16,30</sup> and then to 4 (-91.5 ppm). The -91.5 ppm  $^{29}$ Si NMR resonance of 4 is comparable to those for 6  $(-100.7 \text{ and } -101.6 \text{ ppm})^{26}$  The carbonyl <sup>13</sup>C NMR resonance (142.5 ppm, in THF-d<sub>8</sub>) of 4 is similar to that for  $[(Me_5C_5)_2SiO_2CO]_2$  (143.9 ppm)<sup>24</sup> and for 6 (148.8 and 148.9 ppm).<sup>26</sup> While the infrared (IR) absorption of the Si=O stretch in 4 (1165 cm<sup>-1</sup>) is similar to that of the **4-Ph** model (1169 cm<sup>-1</sup>), the  $\nu$  (C=O) band is red-shifted from the  $(SiO_2)_2CO_2$  model (1911 cm<sup>-1</sup>) to the 4-Ph model (1806 cm<sup>-1</sup>), and then to 4 (1751 cm<sup>-1</sup>).<sup>23</sup> Moreover, the C= O stretching mode (1751 cm<sup>-1</sup>) of 4 compares well to that for a bridged silicon carbonate species  $(1780 \text{ cm}^{-1})^{22}$  and for metal carbonates (1776 and 1781 cm<sup>-1</sup>) which were formed via CO<sub>2</sub> adsorption on the surfaces of metal oxide catalysts.<sup>35</sup>

Monomeric  $(SiO_2)_2CO_2$  in the gas phase (Figure 2b) is planar with  $C_{2\nu}$  symmetry.<sup>23</sup> Due to the coordination of two carbene ligands, however, in the solid state the (SiO<sub>2</sub>)<sub>2</sub>CO<sub>2</sub> core in 4 adopts  $C_2$  symmetry with the terminal oxygen atom at each silicon atom residing at each side of the almost planar sixmembered Si<sub>2</sub>CO<sub>3</sub> ring (Figure 2a). The Si-O<sub>terminal</sub> bonds in 4 [1.521(4) Å, av], comparing well to those for  $(SiO_2)_2CO_2$  (1.512 Å),<sup>23</sup> **2** [1.5347(18) Å], and 3 [1.5260(14) Å],<sup>16</sup> are the shortest among the reported Lewis base stabilized Si=O double bonds [1.526(3)-1.579(3) Å]. <sup>28,36,37</sup> The Si-O<sub>ring</sub> bonds in 4 (1.651 Å, av), similar to that in the  $(SiO_2)_2CO_2$  model (1.647 Å, av),<sup>23</sup> are significantly longer than the Si– Oterminal bonds in 4 [1.521(4) Å, av]. The nonbonded siliconsilicon distance in 4 (2.944 Å) is much longer than that in 6  $(2.4151 \text{ Å})^{26}$  and the sum of silicon covalent radii  $(2.34 \text{ Å})^{.36}$ While the five-coordinate silicon atoms in 6 adopt a distorted trigonal bipyramidal geometry,<sup>26</sup> the four-coordinate silicon atoms in 4 have a distorted tetrahedral geometry. The Si-C bond distances in 4 (1.929 Å, av) correspond to the usual Si-C<sub>NHC</sub> bond distances. The C=O bond distance in 4 [1.185(5) Å] is similar to that in a bis(silyl) carbonate  $[1.198(5) \text{ Å}]^{29}$  and in 6 [1.201(2) Å].26

To further probe the bonding nature of 4, the DFT computation of the geometry and electronic structure of the simplified model 4-Ph [optimized in  $C_2$  symmetry), L: =  $:C\{N(C_6H_5)CH\}_2$ ] was performed using the B3LYP/6-311+G\*\* level of theory. In contrast to the almost planar Si<sub>2</sub>CO<sub>3</sub> ring in 4 [O(4)-Si(1)-O(1)-C(55) torsion angle =  $2.1^{\circ}$ ], the Si<sub>2</sub>CO<sub>3</sub> ring in 4-Ph is somewhat distorted [O(4)-Si(1)-O(1)-C(55) torsion angle =  $-28.4^{\circ}$ ]. This suggests that the planar conformation of the Si<sub>2</sub>CO<sub>3</sub> ring in 4 may be ascribed to the steric effect of the carbene ligands and crystal packing effects. The bond distances computed for 4-Ph  $[d_{Si-O(ring)} = 1.683 \text{ Å (av)}; d_{Si-O(terminal)} = 1.545 \text{ Å (av)}; d_{Si-C} = 1.953 \text{ Å (av)}]$  are comparable to those of 4  $[d_{Si-O(ring)} = 1.651 \text{ Å (av)}; d_{Si-O(terminal)} = 1.521(4) \text{ Å, (av)}; d_{Si-C} = 1.929 \text{ Å (av)}]$ . Natural bond orbital (NBO) analysis shows that the Si-C bonds (Figure 3a) in 4-Ph [Wiberg bond index (WBI) = 0.59].

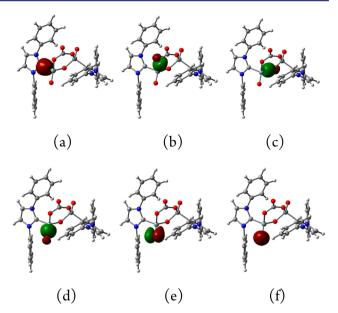
bonds (Figure 3a) in 4-Ph [Wiberg bond index (WBI) = 0.59], similar to those of 2-Ph and 3-Ph, are strongly polarized (78.7%) toward carbon. For 4-Ph, the Si-O<sub>terminal</sub>  $\sigma$ -bond

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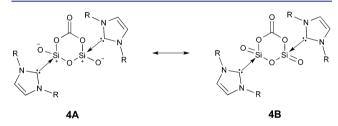


**Figure 2.** (a) Molecular structure of 4. Thermal ellipsoids represent 30% probability. Hydrogen atoms omitted for clarity. Selected bond distances (Å) and angles (deg):  $Si(1) \cdots Si(2)$  2.944, Si(1) - O(1) 1.666(4), Si(1) - O(4) 1.629(4), Si(1) - O(5) 1.515(4), Si(1) - C(1) 1.926(5), C(5S) - O(1) 1.329(6), C(5S) - O(2) 1.339(6), C(5S) - O(3) 1.185(5), C(1) - Si(1) - O(1) 101.80(18), C(1) - Si(1) - O(4) 105.2(2), C(1) - Si(1) - O(5) 108.9(2), Si(1) - O(4) - Si(2) 129.11(19). (b) The  $(SiO_2)_2CO_2$  model (optimized in  $C_{2\nu}$  symmetry). Selected bond distances (Å) and angles (deg): Si(1) - O(1) 1.653, Si(1) - O(4) 1.641, Si(1) - O(5) 1.512, C(1) - O(1) 1.370, C(1) - O(3) 1.178, Si(1) - O(4) - Si(2) 129.4, O(1) - Si(1) - O(4) 103.8, O(4) - Si(1) - O(5) 129.5, O(1) - Si(1) - O(5) 126.7, O(1) - C(1) - O(2) 114.7, O(1) - C(1) - O(3) 122.6.

(Figure 3d, 81.4% toward O and 18.6% toward Si) is less polarized than the Si– $O_{\rm ring}$   $\sigma$ -bonds [Figure 3b–c, 86.3% toward O (av) and 13.7% toward Si (av)]. This may be due to the fact that the two degenerate lone pair orbitals for each terminal oxygen atom (residing at silicon) in 4-Ph (one of them is shown as Figure 3e) are significantly distorted toward silicon. In addition, the 1.10 Si– $O_{\rm terminal}$  WBI value for 4-Ph, similar to those for 2-Ph (1.05) and 3-Ph (1.11), is approximately double those (0.51 and 0.56) for the Si– $O_{\rm ring}$  bonds in 4-Ph, revealing the modest double bond character of the Si– $O_{\rm terminal}$  bond in 4 (see the resonance structure 4B in Figure 4). Meanwhile, for 4-Ph, each silicon has a +2.19 positive charge, whereas the oxygen atoms in the ring and at the terminals of the silicon atoms have a –0.89 to –1.26 negative charge. In terms of both LMOs and NBO analysis of 4-Ph, the



**Figure 3.** Selected localized molecular orbitals (LMOs) of **4-Ph.** (a) Si–C  $\sigma$ -bonding orbital; (b and c) Si–O<sub>ring</sub>  $\sigma$ -bonding orbitals; (d) Si–O<sub>terminal</sub>  $\sigma$ -bonding orbital; (e and f) lone pair orbitals of O<sub>terminal</sub>



**Figure 4.** Resonance contributors of **4.** Zwitterionic **4A** represents the major resonance structure.

zwitterionic resonance structure 4A (Figure 4) may represent the predominate formulation of 4.

As an extension of our recent work on carbene-stabilized  $Si_2O_3$ ,  $Si_2O_4$ , and  $P_2O_4$ ,  $^{16,33}$  synthesis of 4, the first carbene-stabilized silicon—carbon mixed oxide, indicates that carbenes may be also employed in stabilizing highly reactive mixed main group oxide clusters.

#### ASSOCIATED CONTENT

## S Supporting Information

Complete ref 23, full details of the syntheses, computations, and X-ray crystal determination, including cif files. The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/jacs.5b05202.

#### AUTHOR INFORMATION

# **Corresponding Author**

\*robinson@uga.edu

#### Notes

The authors declare no competing financial interest.

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